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A class of non-local contact processes is introduced and studied using mean-eld approximation and numerical simulations. In these processes particles are created at a rate which decays algebraically with the distance from the nearest particle. It is found that the transition into the absorbing state is continuous and is characterized by continuously varying critical exponents. This model diers from the previously studied non-local directed percolation model, where particles are created by unrestricted Levy ights. It is motivated by recent studies of non-equilibrium wetting indicating that this type of non-local processes play a role in the unbinding transition. O ther non-local processes which have been suggested to exist within the context of wetting are considered as well. The contact process (CP) is known as a simple model for epidem ic spreading that m in – ics the interplay of local infections and recovery of individuals [1, 2]. It is de ned on a d-dimensional lattice whose sites could be either active (infected) or inactive (non-infected), denoted as '1' and '0', respectively. The model evolves random -sequentially by two competing processes, namely, nearest-neighbor infections 01=10 ! 11, and spontaneous recovery 1 ! 0. Depending on the relative frequency of these moves the contact process displays a continuous phase transition from a uctuating active state into an absorbing state which belongs to the universality class of directed percolation (DP) [3, 4, 5, 6].

In the present paper we investigate a generalized version of the one-dimensional contact process where inactive sites can be activated over long distances. We consider a lattice model where sites could be either active or non-active. The model evolves by random sequential updating with the following transition rates:

$$1 ! 0 w ith rate 1$$
 (1)

$$0! 1$$
 with rate q=1 (2)

The rst m ove corresponds to the usual local annihilation process, while the second m ove describes a long range process in which an inactive site which is located at a distance 1 from the nearest active one becom es active. The rate at which such a process takes place decays algebraically with the distance 1 from the nearest active site (m easured in lattice site units), rejecting the long range nature of the interaction. The overall rate of this process is governed by the control parameter q, while the characteristic shape of the interaction is controlled by the exponent . In particular, usual short range dynamics is recovered in the limit ! 1 . In what follows we refer to this model as the -process. Note that its de nition is valid in any dimension although we are primarily interested in the one-dimensional case.

The long-range contact process investigated here is motivated by recent studies of depinning transitions in non-equilibrium wetting processes [7, 8, 9, 10, 11], where one considers a uctuating interface next to a hard-core wall. Regarding the pinned dom ains of the interface as active sites and unpinned dom ains as inactive ones, the dynam ics of the uctuating interface m ay be projected onto that of a contact process (see Fig. 1). For example, unpinning of the interface due to deposition would correspond to spontaneous recovery 1 ! 0,

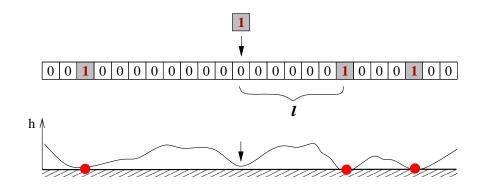


FIG. 1: Long-range infections in the generalized one-dimensional contact process. Any site between two active sites can be activated with a rate proportional to 1 , where lis the distance to the nearest active site. The model is motivated by the dynamics of a uctuating interface growing on an inert substrate (see text).

while lateral growth of a pinned dom ain would correspond to local spreading of activity by 01=10 ! 11. However, as unpinned regions of the interface uctuate in the bulk they m ay spontaneously become pinned to the substrate far away from other binding sites. As illustrated in the gure, such a pinning electively leads to long-range infections in the corresponding contact process. Clearly, the rate for pinning will decrease as we move away from the binding site. Numerical studies of some wetting models (not shown in this work) indicate that this rate decays algebraically as 1 with an exponent 2:6. This motivates the postulated power law in Eq. (2). Nevertheless the relation between non-equilibrium wetting and the -process should be considered as an analogy, rather than an exact m apping, because the projection neglects the internal dynam ics of unpinned regions of the interface.

In recent years the contact process has also been generalized in various other ways to include long-range infections [12, 13]. In these studies it is assumed that a given active site can activate any other site with a probability P(k), which decays algebraically with the distance k as

In such models the infection can be thought of as being spread by Levy ights [14]. Janssen et al. solved this problem using eld-theoretic renorm alization group calculations [15]. The results of this analysis is in agreement with numerical simulations [16]. More recently these studies have been extended to contact processes with temporal [17] and spatio-temporal Levy ights [18] as well as to systems with disorder [19].

The -process studied in the present work di ers from Levy- ight-m ediated contact process. Here an inactive site can only be activated by the nearest active site. Therefore, in one space dimension, the interaction range is electively cut o by half the actual size of the corresponding island of inactive sites. Thus infections in the -process are mediated by truncated Levy ights, which cannot overtake other active sites. As will be shown below, this truncation changes the critical properties at the transition significantly. In particular, although both models exhibit critical exponents which vary with , the exponents them – selves are not the same. Moreover, while in the Levy ights model the exponents become mean-eld like for small [4] no such regime exists in the -process.

In the following section we analyze the -process by a mean-eld approximation as well as numerical simulations and compare it to contact processes with unrestricted Levy ights. In Sect. III we further generalize the model by taking the rate for nearest-neighbor infection to depend on the distance to the nearest active site. This rate is controlled by an additional exponent . The phase diagram of this generalized model, called - -process, is then studied by mean-eld and numerical methods. Conclusions are nally presented in Sect. IV

II. ANALYSIS OF THE MODEL

A. M ean-eld approxim ation

We now consider the process within a mean-eld approximation in terms of the density of active sites (t). To this end the mean-eld equation of the ordinary contact process has to be extended by a term that accounts for long-range infections according to Eq. (2). A ssum ing that the sites of a one-dimensional lattice are uncorrelated and independently active with probability , it is easy to check that the probability of an inactive site to lie at a distance 1 from the nearest active site is $(1 (1)^2)(1)^{212}$. Summing up the contributions for all distances 1, the mean-eld equation governing the dynamics of the density of active sites takes the form

$$\theta_t = + q (2) \qquad \sum_{l=1}^{X^l} \frac{(1)^{2l}}{l} :$$
(4)

where the rst term appearing on the rh.s. of Eq. (4) corresponds to the short range annihilation process. Note that the usual DP short range activation term is given by the rst term of the sum in the rh.s. of Eq. (4)

Turning the sum into an integral the leading term s in in the dynamical equation (4) may be evaluated. It is found that for < 1 and, to leading order in , Eq. (4) becomes

$$\theta_t = r + u \tag{5}$$

where (r;u) are constants and u > 0. Since the leading term in this equation is , and since its coe cient is positive, the absorbing state (=0) is always unstable and no transition takes place for any nite q. This is also the case for = 1, where logarithm ic corrections to the leading linear terms destabilize the absorbing phase.

On the other hand, for 1 < < 2 the leading term in the equation is the linear one. Moreover the coe cient u of the leading non-linear term is negative. This results in a continuous transition to the absorbing state which takes place at r = 0 corresponding to a non-vanishing rate q. Such a phase transition belongs to a universality class di erent from the one of the short range DP m odel. For example, in the stationary state the density of active sites scales as

$$_{\rm stat}$$
 $r^{1=(1)}$; (6)

hence the mean-eld order parameter exponent, $MF = \frac{1}{1}$, varies continuously with . It diverges in the limit ! 1. For 2, however, the leading non-linear term is v² where v is a negative constant. The mean-eld equation thus reduces to that of the short range DP process, and usual DP-like transition is expected.

Thus

$${}^{MF} = \begin{cases} 8 \\ < \frac{1}{1} \\ 1 \end{cases} \qquad 1 < < 2 \\ : 1 \qquad 2 : \end{cases}$$
(7)

Before discussing the results of the numerical study of this model we consider a more re ned mean-eld approximation, where the elect of the long-range process on the dilusion constant is taken into account. To proceed we assume that, although the dynamical process is long range, it does not modify the usual Laplacian form of the spatial interactions, D r². The reason is that the infection range in the {model is cut-oligy the maximal distance to the nearest active site, m aking it electively of nite range. However, as we shall see below, the elect of the infection process is to m ake the dilusion coellcient D dependent on the density .

In order to evaluate D () we note that the infection process is cut o at length-scales l_{av} 1=, which is the average distance between active particles in a system with density. The mean square displacement of an infection is expected to scale as

$$hl^{2}i \qquad dll^{2} \qquad {}^{3} + D_{0}: \qquad (8)$$

where is a cuto due to lattice spacing from which the usual constant contribution D $_0$ (positive for > 3) to the di usion coe cient arises. Since D () hl 2 i, Eq. (8) suggests that the elective di usion constant diverges for < 3. Thus the space-time-dependent version of the mean-eld equation for 1 < < 2 reads to low est order

$$Q_{t} (x;t) = r (x;t) + u[(x;t)] + [(x;t)]^{3} r^{2} (x;t):$$
(9)

For this equation, dimensional analysis yields the complete set of mean-eld exponents

$$\frac{MF}{2} = \frac{MF}{1} = \frac{1}{1}; \quad \frac{MF}{k} = 1;$$
 (10)

where as usual $\frac{M}{2}^{F}$ and $\frac{M}{k}^{F}$ are the mean-eld values for the spatial and tem poral exponents which control the power-law divergence of correlations (respectively in space and time) at criticality.

On the other hand for 2 < < 3 the non-linear term in the dynam ical equation u becomes v² while the di usion coe cient remains singular at = 0. This implies that the DP regime sets up only for 3, and not for > 2 as suggested by the analysis of the reaction terms alone. In particular, for 2 < 3 lowest order mean-eld reads

$$\Theta_{t} (x;t) = r (x;t) + v[(x;t)]^{2} + [(x;t)]^{3} r^{2} (x;t):$$
(11)

and by dim ensional analysis one gets

$$\frac{MF}{2} = 2 - \frac{1}{2}; \quad MF = \frac{MF}{k} = 1:$$
 (12)

For the dynamical exponent $z = k = \frac{2}{8}$, we obtain

$$z^{MF} = \begin{cases} 2 & 1 & 1 < < 2 \\ \frac{2}{4} & 2 & 3 \\ 2 & > 3 \end{cases}$$
(13)

In the following we compare these values with the results of extensive num erical simulations.

B. Num erical results

In order to determ ine the critical exponents num erically, we perform ed M onte-C arb sim – ulations of the one-dimensional -process with periodic boundary conditions, starting with a fully occupied lattice. The time step dt of a single m ove in the random sequential updating procedure has been taken as 1=L, where L is the lattice size.

For models with long-range interactions such simulations are dicult to perform because of strong nite-size e ects, which increase as ! 1. In the present model these nite-size e ects manifest them selves by sudden transitions into the absorbing state. This leads to uncontrollable uctuations in the statistical averages. To circum vent this problem we com – bined nite size scaling analysis with num erical simulations. The simulations were carried out on large system s with hom ogeneous initial states approaching the critical point from the active phase.

The critical point q and the dynamical exponent z have been determined by nite size analysis of the average absorbing time for an initially fully occupied lattice. At the critical point is expected to scale with the system size L as

$$L^{z}$$
: (14)

For one dimensional system s belonging to the DP universality class the dynam ical exponent is known to be $z^{0.P} = 1.580745(10)$ [21]. We also measured the exponent $= =_k$, which is associated with the temporal decay of the density of active sites at criticality. This calculation has been performed by applying the method of nite{size analysis proposed by de O liveira and D ickm an [22]: whenever the system falls into the absorbing state the dynam ical process is recovered by automatically resetting the system into a \typical" active con guration. In practice, this procedure suppresses the large uctuations which result from the abrupt transitions to the absorbing state in nite system s. A simple scaling argument shows that the stationary density at criticality should scale with the system size as

stat
$$L^{z}$$
: (15)

F in ite size analysis has been performed by averaging over 10^3-10^4 independent runs.

For > 2:0 the estimates of the exponent, obtained by nite size analysis, have been compared with the standard analysis, based on the time-decay of (t) at criticality.

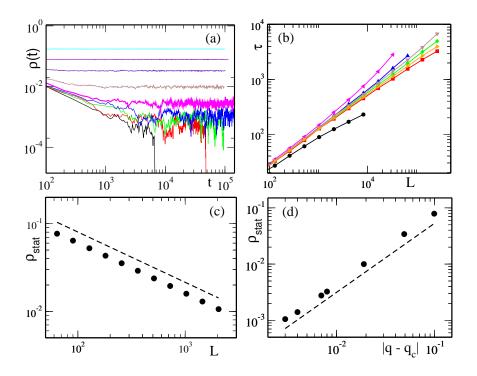


FIG. 2: Results of the numerical analysis of the -process for = 1.5. All plots are in double-logarithmic scale. a) Density of active sites (t) as a function of time measured for a system of size $L = 2^{20}$ starting from a fully occupied lattice. In the active phase and close to the critical value $q_c = 0.4695(5)$ (from top to bottom q =0.679; 0.569; 0.519; 0.489; 0.477; 0.473; 0.472; 0.471; 0.470) nite-size uctuations yield sudden transitions to the absorbing state. b) Finite-size scaling analysis of the average absorbing time . From top to bottom q = 0.475; 0.471; 0.470; 0.469; 0.468; 0.467; 0.45. c) Finite-size scaling analysis of the stationary density stat (see text). d) Stationary density stat as a function of the distance from q_c . The dashed lines in panels c-d are the best t (see table I).

U sually, large uctuations make the latter m ethod quite inaccurate and time consuming. In order to obtain better performances we carried out numerical simulations of large systems $(L = 2^{20} - 2^{21})$ and over long time lapses $(10^5 - 10^6 \text{ time steps})$, while averaging over a few diment realizations. G ood agreement with the predictions of nite{size analysis is found.

The critical exponent has been determined by measuring the stationary density of active sites (q q_c) in large systems (L = 2^{15} 2^{18}) for dierent values of q, just above q_c .

The estim ated values for the exponents and can be compared with the best num erical

	q _c	Z			^{M F} = ^{M F}	$Z^{M\ F}$
12	0205(3)	0:34(2)	2:0(1)	2 : 73 (15)	5	02
1:5	0 : 4695 (5)	0 : 67 (2)	0 : 84 (4)	125(5)	2	0:5
1:8	0 : 714(1)	0 : 99(5)	0 : 46(3)	0 : 68 (7)	125	0 :8
2 : 0	0 : 8592 (2)	121(2)	0:31(1)	0:49(2)	1	1
2:1	0 : 9250 (3)	1:25(2)	0:28(1)	0:46(2)	1	1 : 0526 :::
23	1:0453(2)	1:43(2)	0:22(1)	0:36(1)	1	1:1764 :::
2:5	1:1492(2)	1:48(4)	0:19(1)	0:32(1)	1	4=3
2 : 6	1:1955(2)	1:54(3)	0 : 175 (10)	0:30(1)	1	1 : 4285 :::
2 : 7	1:2381(2)	1:56(2)	0 : 17(1)	0294(8)	1	1 : 5384 :::
3 : 0	1:3470(2)	1:58(2)	0:166(8)	0:278(8)	1	2

TABLE I: Estimates of the critical points and exponents for various values of . These values are plotted in Fig. 3. For comparisons mean eld values are also reported.

estimates of the DP exponents in one dimension, $^{DP} = 0.159464(6)$ and $^{DP} = 0.276486(8)$ [21]. Typical curves resulting from this numerical procedure are shown in Fig. 2 for = 1.5.

As sum marized in Table I, the num erical results show a qualitative agreement with the mean-eld predictions. In particular, it is found that all exponents vary as is increased up to a critical value , beyond which they become consistent (within num erical error) with the DP values. As approaches 1, the exponents and are found to increase, while the dynamical exponent z vanishes as 1. The comparison between num erics and mean-eld is shown in Fig. 3.

Note that according to num erical results the crossover to the DP scaling regime seems to take place at 2:7. On the other hand, the mean-eld predicts that the crossover takes place in two steps: rst, and become DP-like at = 2 and then the exponent z assumes its DP value at = 3.

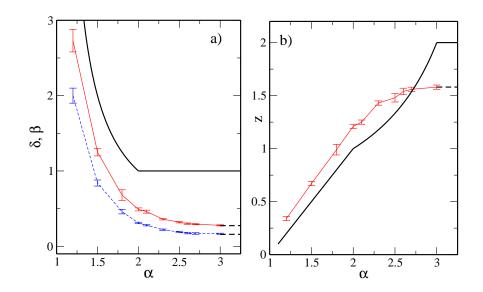


FIG. 3: C on parison between numerical estimates (including error bars) and the mean-eld predictions for the critical exponents as a function of the control parameter . a) The exponents (thin solid line), $= =_k$ (thin dashed line) and the mean-eld prediction (thick solid line); note that $^{MF} = ^{MF}$. b) The dynamical exponent $z =_k = \frac{1}{2}$ (thin solid line) and the mean-eld prediction (thick solid line). The thick dashed lines on the right of both plots mark the best numerical estimates of the DP exponents in 1D.

C. Comparison with unrestricted Levy ights

A santicipated in the Introduction, it is instructive to compare the results of the -process with those of contact processes with infections mediated by unrestricted Levy ights (see Refs. [15, 16]). In the latter case three di erent dynamical regimes were identied:

a mean-eld regime for < 3d=2 characterized by the critical exponents MF = 1, $\frac{MF}{2} = (d)^{-1}$, and $\frac{MF}{k} = 1$, where d denotes the spatial dimension.

a non-trivial phase for 3d=2 with continuously varying exponents, restricted by the additional scaling relation k_{2} (2d) 2 = 0.

aDP regime for >

Here the upper threshold for can be expressed in term s of DP exponents by $= 2d + z^{DP}$ 2^{DP} $= \frac{DP}{2}$ 3:0766(2). The phase structure of this model exhibits a mean eld regime for < 3d=2 which is not present in the -process. In this mean eld regime the unrestricted Levy ights become so long-ranged that spatial uctuations are destroyed, leading to a hom ogeneous distribution of active sites. In the present model, however, the long-range interactions are electively cut o at the distance to the nearest active site, hence there is no direct communication by long-range interactions between adjacent intervals of inactive sites. This restriction yields non-trivial correlations.

It is instructive to compare m ean-eld equation (9) with the corresponding equation for unrestricted Levy ights, which { according to the present notation { can be written as

$$Q_t (x;t) = n (x;t)$$
 $^2 (x;t) + Dr ^1 (x;t)$: (16)

Here r¹ is a symmetric fractional derivative, which generates unrestricted Levy ights. C learly, this equation has scaling properties dimension (9). For instance, within the mean-eld approximation the exponent is equal to 1. Therefore, it is likely (?) that also in low dimensions models with truncated and unrestricted Levy ights belong to dimension universality classes.

D. The -process in higher dim ensions

The -process and its mean-eld equation can be easily generalized to d > 1. In this case the range, l, of the activation process of an inactive site located at i is given by the radius of the maximal "empty" (inactive) sphere centered in i. W ithin the mean-eld approximation the average volume of the "empty" spheres is proportional to 1=, so that the average radius of empty spheres is < 1 > / ^{1=d}. Moreover, the di usion coe cient D () can be easily computed by extending Eq. (8) to arbitrary dimension d

D()
$$\frac{d^2}{d^2} + D_0$$
 (17)

Therefore, the corresponding m ean-eld equation reads

$$\theta_t = r \quad u^{-d} \quad v^2 + D()r^2 + o(^2);$$
(18)

where r(q) vanishes at the critical point while u(q) and v(q) are positive constants. As in the 1d case, if < d the absorbing state cannot be reached and there is no transition. On

the other hand, for > 2d and d = 2 a DP regime sets in, where both leading terms in the dynam ical equation and in the di usion constant become DP-like. In the range d < < 2d the system displays a non-trivial transition, with continuously varying critical exponents. In summary, the mean-eld exponents for d = 2a are

$$_{k}^{MF} = 1;$$
 (19)

$$MF = MF = k = \frac{1}{k} = \frac{1}{-d \ 1} \quad d < < 2d$$

: 1 > 2d (20)

and

$${}_{2}^{MF} = \frac{{}_{k}^{MF}}{Z^{MF}} = \frac{\begin{pmatrix} 8 \\ -1 \\ -d \end{pmatrix}}{\begin{pmatrix} 1 \\ -d \end{pmatrix}} d < \langle d+2 \\ \vdots \\ \frac{1}{2} \\ d+2 \end{pmatrix} (21)$$

III. GENERALIZATION OF THE MODEL

A. The -process

In a recent paper we studied a di erent version of a contact process with long-range interactions, called -process [23]. In this model infections are short-ranged, i.e., active sites can only activate their nearest neighbors, but the rate for short-range infections depends algebraically on the distance m to the nearest active site before the update. Speci cally, the -process is de ned by the transition rates

$$1! 0$$
 with rate 1 (22)

$$10;01 ! 11 \text{ with rate } q(1 + a = m)$$
 (23)

where m denotes the distance to the next active site. Here a is a constant, q is again the control parameter, and is an exponent controlling the characteristics of the interaction. It turns out that for > 1 the transition belongs to the DP universality class, while for 0 < < 1 the transition becomes rst order.

The model was introduced as a toy model in order to explain why non-equilibrium wetting processes, with a su ciently strong attractive short-range force between interface and substrate, can exhibit a rst-order transition. In this case the growth rate in the bulk is positive, so that spontaneous pinning far away from the edges can be neglected, meaning that the transition is driven by unpinning and spontaneous growth of bound regions. The binding rate, however, was found to vary with the actual size of the unpinned regions, which m otivates the algebraic m-dependent rate in Eq. (23). It should be noted that the -process is mainly relevant for non-equilibrium wetting in one spatial dimension only, where pinned sites e ectively separate depinned islands into non communicating regions. M oreover, there is no unique and straightforward way to extend such a process in higher dimensions. In the follow ing we combine the two long-range processes in a single 1d m odel and study the corresponding phase diagram in the -plane.

B. De nition of the --process

The combined model, which evolves by random sequential update over a time step dt = 1=L is defined by the following transition rates:

10;01 ! 11 with rate
$$q(1 + a=m)$$
 (25)

$$000 ! 010$$
 with rate bq=1 (26)

where m is the size of the inactive island and l denotes the distance from the nearest active site. Here q is the control parameter, and are the control exponents, and a and b are constants. The \pure" - and - processes are recovered in the limits ! 1 and ! 1, respectively.

C . M ean-eld analysis and num erical simulations

Neglecting spatial uctuations, the mean eld equation of the combined -process (see Sec. IIA and [23]) becomes

$$\Theta_{t} = + q^{2} \prod_{m=1}^{X^{t}} (1 + \frac{a}{m}) (1)^{m} + bq (2)^{m} \prod_{l=2}^{X^{t}} \frac{(1)^{2l}}{l} (1)^{2l} (27)$$

In the regime of interest, namely for 0 < < 1 and 1 < < 2, the mean-eld equation can be written to leading order as

$$\theta_t = r + p^{1+} u + 0(2);$$
(28)

where r;p and u are q-dependent constants:

$$r = q + bq \frac{2^2}{1};$$
 (29)

$$p = aq (1);$$
 (30)

$$u = bq \frac{2^{-1}}{1} (2)$$
 : (31)

Note that these are approximate expressions, as they are obtained by substituting the sum s in (27) by integrals to obtain simple analytic expressions. This approximation does not a ect the sign of p and u which turn out to be positive constants in the regime of interest. A coordingly, if the leading nonlinear term is ¹⁺ (i.e. < 1), the transition is rst order. On the other hand, if the leading nonlinear term is (> 1), the critical behavior of the pure -m odel is recovered. Thus, the mean-eld approach predicts that the critical exponents are independent of . O ne can add the e ect of the long range processes on the di usion constant as was done in Sec. IIA. It is readily seen that the critical exponent z assumes its DP value for > 3 as long as > 1.

The mean-eld phase diagram is shown in Fig. 4. It contains four di erent phases:

- (i) a D P phase for > 1; > 3,
- (ii) a continuously varying exponent phase CVE1 for > 1 and 1 < 2 where the transition is second order with continuously varying exponents ; and z.
- (iii) a continuously varying exponent phase CVE2 for > 1 and 2 < < 3 where the transition is second order but where z is the only continuously varying exponent.
- (iv) a phase for < 1 and 0 < < 1

where the transition is discontinuous.

Num erical simulations have been performed for testing the predictions of the mean-eld phase diagram. In these simulations we have taken a = 2 and b = 1.

An extensive num erical study of the phase-diagram of the - process is time consum ing and was not tackled in the present paper. Rather, we restricted our analysis to a small num ber of cuts in the - plane in order to test the validity of the mean-eld predictions. We nd that while the general features of the phase-diagram are correctly reproduced by

	2.0	23	2.5	2.6	2.7	3.0
q_{c}	0 : 7783 (2)	0 : 9308 (3)	1 : 0155 (3)	1 : 0530 (3)	1 : 0880 (5)	1:1785 (5)
Z	1.18(3)	1.40(3)	1,51(3)	1,50(4)	1,54 (5)	1,57 (3)
	0.32(2)	0,22(1)	0.19(1)	1.18(1)	1.18(1)	1,16(1)
	0.52(1)	0.37(3)	0.32(3)	0.30(2)	0,29(1)	0,28(2)

TABLE II: process: Estimates of the critical points and exponents for = 2 and various values of . O ther parameters have been xed to a = 2 and b = 1

the mean-eld, the location of the transition lines and the values of the critical exponents are changed.

The num erical method proposed in [22] has been applied for the inspection of the phase diagram along the line = 2 for a discrete set of values of ranging between 2 and 3. In these simulations we have used the same system sizes and conditions described in II. The num erical simulations suggest that in fact there is a single phase with continuously varying exponents (CVE) rather than two as predicted by the mean eld. In this phase all critical exponents are continuously varying with . Both in the DP and CVE regions the critical exponents coincide, within num erical accuracy, with those found for the pure -m odel (i.e.,

! 1). The results reported in Table II are in agreement with the mean-eld prediction that scaling properties in the critical regions are independent of the process. It is worth stressing that even for nite values of the boundary between the DP and the CVE region is located close to 2:7. The position of the boundary line for = 1 and = 2 is marked by crosses on the phase diagram (see Fig. 4)

We now consider the boundary between the $rst{order and the DP regions.$ For the pure -m odel (i.e., ! 1) this boundary was investigated numerically in Ref. [23]. Following ([23]) we determ ine the nature of the phase transition for nite by studying the size distribution of inactive domains in stationary active state. At the transition to the absorbing state this distribution is expected to exhibit a power law tail P (m) m for large inactive domains of size m. By numerically determining the exponent, the nature of the transition may be deduced. For > 2 the average domain size is nite at the transition and thus it is rst order. On the other hand for 2 the average domain size diverges

	0.5	0.7	0.8	0.9	1.1	15
\mathbf{q}_{c}	0 : 9515(5)	1:0184(1)	1 : 0430 (5)	1 : 0647 (3)	1:0992(1)	1:1445(5)

TABLE III: -process: estim ates of the critical points q_c for = 3, a = 2, b = 1 and various values of .

at the transition and thus the transition is continuous. In particular, for DP, where the transition is continuous, one has $DP = 2 = \frac{1}{2}$ / 1:747.

We have analyzed the nature of the phase transition for = 3 at some values of ranging between 0.5 and 2. We nd that $= {}^{DP}$ for > 0.8 indicating that the transition to the absorbing state is of DP nature. On the other hand for < 0.8 we nd > 2, indicating a rst order transition. The position of the boundary line for = 1 and = 3 is marked by dots on the phase diagram (see Fig. 4).

Details of the numerical analysis is presented in Fig. 5. In this gure we not illustrate the method for identifying the transition point. This is done by plotting (t)t ^{p p} as a function of t for dimension of q and searching for the q value for which this quantity approaches a constant. The data were obtained for for quite large system sizes (L 2^{18} 2^{19}) and hom ogeneous initial conditions. We then display the distribution function P (m) at the transition, and determ ine the exponent which controls its large m behavior. The value of the control parameter q at the transition point is given in Table III for = 3 and several values of the parameter .

Our num erical results suggest that the boundary between rst order and DP like behavior varies with . In particular it takes place at ' 0.8 for = 3 while it is ' 1 in the lim it of in nite . Thus the boundary line in the plane is not parallel to the axis at variance with mean eld prediction.

IV. CONCLUSIONS

In m any cases it is useful to project com plex dynam ical processes onto sim pler ones which could be m ore readily analyzed. In doing so it m ay happen that the local dynam ics of the

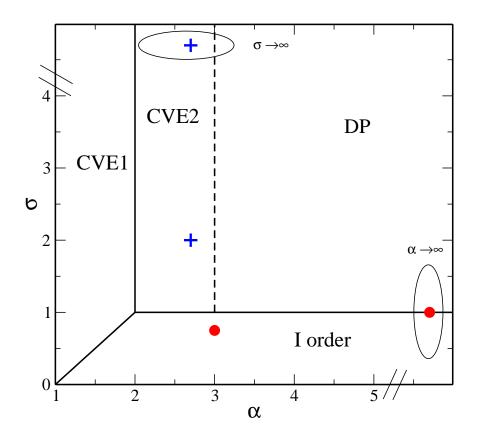


FIG.4: Mean-eld phase diagram of the --process. Four dierent regions are identied corresponding to dierent types of transitions to the absorbing state: a DP region, a region of a rst order transition and two regions of continuously varying critical exponents as explained in the text. We also indicate the of the phase boundary lines as determ ined by numerical simulations: full dots for the DP-rst order boundary and crosses for the DP-CVE boundary. The numerical results suggest the existence of a single CVE phase with a single DP-CVE line located at 2:7.

originalm odel is translated into a non-local dynam ics of the projected m odel. For example it has been argued that when the dynam ics of uctuating interfaces interacting with a wall is projected onto the dynam ics of a contact process di erent types of long range processes m ay take place.

M otivated by this observation we introduced a non-local version of the contact process where particles are created with a rate which decays like 1 with the distance 1 from the nearest particle. M ean-eld analysis shows that the critical exponent associated with the transition to the absorbing state varies continuously with for 1 < 2 and it diverges for approaching 1. The usual short range m ean-eld exponent = 1 is recovered above

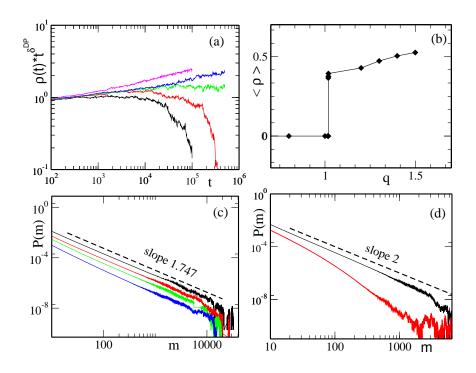


FIG. 5: Numerical study of the -process for = 3.0. a) (t)t ^{or v} vs t for = 0.8 and values of the control parameter close to q_c 1.043 : from top to bottom q = 1.045; 1.044; 1.043; 1.042; 1040 . b) stationary density _{stat} as a function of q for = 0.7: a jump occurs at the rst-order transition point q_c 1.0184 . In c) and d) we display the probability distribution of the size of inactive dom ains P (m) at the transition. c) from top to bottom = 1.5; 1.1; 0.9; 0.8) : the power-law decay agrees with the DP scaling (see dashed line). d) from top to bottom = 0.7; 0.5 : P (m) decays faster then m² so that lm i is nite. In both of these plots the curves are not norm alized and have been rescaled to t on the same plot.

the threshold = 2. The exponent $_{k}$ is found to be 1 in the entire range. Numerical studies in one dimension support this general behavior, although the value of and the upper threshold seem to be di erent.

By including spatial uctuations in the mean-eld equations the mean-eld exponents $_{?}$ and z are evaluated. It is found that near = 1 the exponent z vanishes linearly, while it approaches the usual mean-eld value z = 2 at another threshold, which in one dimension is = 3. A loo in this case we nd a qualitative agreement with numerics. Extension of the model to include another long range dynam ical process, the -process, has also been considered using both mean-eld approximation and numerical simulations. Here, too, the global features of the mean-eld phase diagram are qualitatively recovered by the

num erical study.

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